

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/735,928	AKIEDA ET AL.
	Examiner Ellen Kim	Art Unit 2874

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
385	147	11/27/2005	EK
335	156	11/27/2005	EK
345	156	11/27/05	EK